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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Active
Number of LABs/CLBs	896
Number of Logic Elements/Cells	8064
Total RAM Bits	294912
Number of I/O	264
Number of Gates	400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	456-BBGA
Supplier Device Package	456-FBGA (23x23)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc3s400-4fg456c">https://www.e-xfl.com/product-detail/xilinx/xc3s400-4fg456c</a>

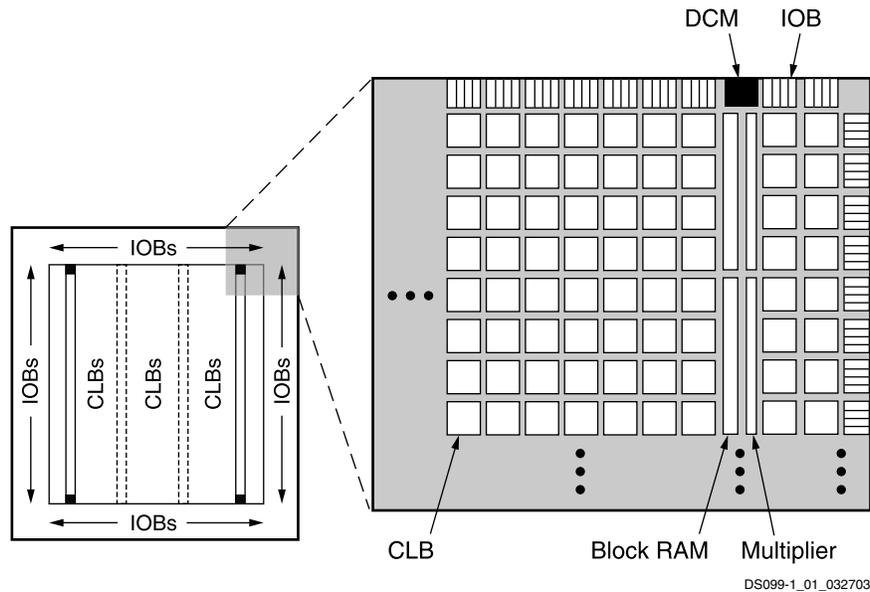
## Architectural Overview

The Spartan-3 family architecture consists of five fundamental programmable functional elements:

- Configurable Logic Blocks (CLBs) contain RAM-based Look-Up Tables (LUTs) to implement logic and storage elements that can be used as flip-flops or latches. CLBs can be programmed to perform a wide variety of logical functions as well as to store data.
- Input/Output Blocks (IOBs) control the flow of data between the I/O pins and the internal logic of the device. Each IOB supports bidirectional data flow plus 3-state operation. Twenty-six different signal standards, including eight high-performance differential standards, are available as shown in Table 2. Double Data-Rate (DDR) registers are included. The Digitally Controlled Impedance (DCI) feature provides automatic on-chip terminations, simplifying board designs.
- Block RAM provides data storage in the form of 18-Kbit dual-port blocks.
- Multiplier blocks accept two 18-bit binary numbers as inputs and calculate the product.
- Digital Clock Manager (DCM) blocks provide self-calibrating, fully digital solutions for distributing, delaying, multiplying, dividing, and phase shifting clock signals.

These elements are organized as shown in Figure 1. A ring of IOBs surrounds a regular array of CLBs. The XC3S50 has a single column of block RAM embedded in the array. Those devices ranging from the XC3S200 to the XC3S2000 have two columns of block RAM. The XC3S4000 and XC3S5000 devices have four RAM columns. Each column is made up of several 18-Kbit RAM blocks; each block is associated with a dedicated multiplier. The DCMs are positioned at the ends of the outer block RAM columns.

The Spartan-3 family features a rich network of traces and switches that interconnect all five functional elements, transmitting signals among them. Each functional element has an associated switch matrix that permits multiple connections to the routing.



**Notes:**

1. The two additional block RAM columns of the XC3S4000 and XC3S5000 devices are shown with dashed lines. The XC3S50 has only the block RAM column on the far left.

Figure 1: Spartan-3 Family Architecture

## Configuration

Spartan-3 FPGAs are programmed by loading configuration data into robust reprogrammable static CMOS configuration latches (CCLs) that collectively control all functional elements and routing resources. Before powering on the FPGA, configuration data is stored externally in a PROM or some other nonvolatile medium either on or off the board. After applying

Table 3 shows the number of user I/Os as well as the number of differential I/O pairs available for each device/package combination.

Table 3: Spartan-3 Device I/O Chart

Available User I/Os and Differential (Diff) I/O Pairs by Package Type																				
Package	VQ100 VQG100		CP132 <sup>(1)</sup> CPG132		TQ144 TQG144		PQ208 PQG208		FT256 FTG256		FG320 FGG320		FG456 FGG456		FG676 FGG676		FG900 FGG900		FG1156 <sup>(1)</sup> FGG1156	
Footprint (mm)	16 x 16		8 x 8		22 x 22		30.6 x 30.6		17 x 17		19 x 19		23 x 23		27 x 27		31 x 31		35 x 35	
Device	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff
XC3S50	63	29	89 <sup>(1)</sup>	44 <sup>(1)</sup>	97	46	124	56	–	–	–	–	–	–	–	–	–	–	–	–
XC3S200	63	29	–	–	97	46	141	62	173	76	–	–	–	–	–	–	–	–	–	–
XC3S400	–	–	–	–	97	46	141	62	173	76	221	100	264	116	–	–	–	–	–	–
XC3S1000	–	–	–	–	–	–	–	–	173	76	221	100	333	149	391	175	–	–	–	–
XC3S1500	–	–	–	–	–	–	–	–	–	–	221	100	333	149	487	221	–	–	–	–
XC3S2000	–	–	–	–	–	–	–	–	–	–	–	–	333	149	489	221	565	270	–	–
XC3S4000	–	–	–	–	–	–	–	–	–	–	–	–	–	–	489	221	633	300	712 <sup>(1)</sup>	312 <sup>(1)</sup>
XC3S5000	–	–	–	–	–	–	–	–	–	–	–	–	–	–	489	221	633	300	784 <sup>(1)</sup>	344 <sup>(1)</sup>

**Notes:**

1. The CP132, CPG132, FG1156, and FGG1156 packages are discontinued. See [http://www.xilinx.com/support/documentation/spartan-3\\_customer\\_notices.htm](http://www.xilinx.com/support/documentation/spartan-3_customer_notices.htm).
2. All device options listed in a given package column are pin-compatible.
3. User = Single-ended user I/O pins. Diff = Differential I/O pairs.

**Package Marking**

Figure 2 shows the top marking for Spartan-3 FPGAs in the quad-flat packages. Figure 3 shows the top marking for Spartan-3 FPGAs in BGA packages except the 132-ball chip-scale package (CP132 and CPG132). The markings for the BGA packages are nearly identical to those for the quad-flat packages, except that the marking is rotated with respect to the ball A1 indicator. Figure 4 shows the top marking for Spartan-3 FPGAs in the CP132 and CPG132 packages.

The “5C” and “4I” part combinations may be dual marked as “5C/4I”. Devices with the dual mark can be used as either -5C or -4I devices. Devices with a single mark are only guaranteed for the marked speed grade and temperature range. Some specifications vary according to mask revision. Mask revision E devices are errata-free. All shipments since 2006 have been mask revision E.

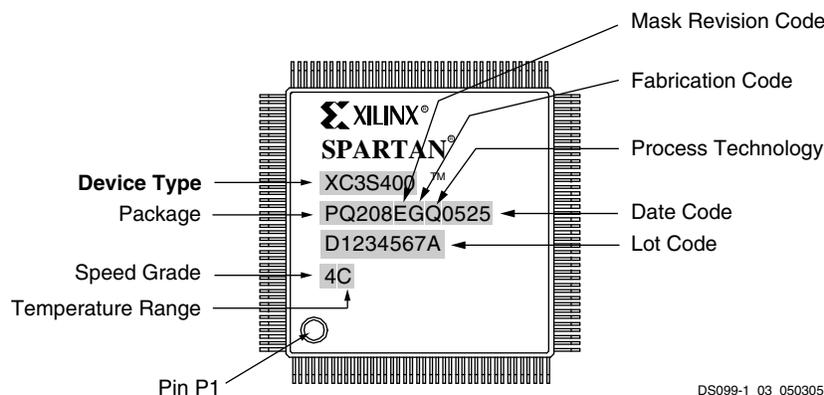


Figure 2: Spartan-3 FPGA QFP Package Marking Example for Part Number XC3S400-4PQ208C

## Function Generator

Each of the two LUTs (F and G) in a slice have four logic inputs (A1-A4) and a single output (D). This permits any four-variable Boolean logic operation to be programmed into them. Furthermore, wide function multiplexers can be used to effectively combine LUTs within the same CLB or across different CLBs, making logic functions with still more input variables possible.

The LUTs in both the right-hand and left-hand slice-pairs not only support the logic functions described above, but also can function as ROM that is initialized with data at the time of configuration.

The LUTs in the left-hand slice-pair (even-numbered columns such as X0 in [Figure 11](#)) of each CLB support two additional functions that the right-hand slice-pair (odd-numbered columns such as X1) do not.

First, it is possible to program the “left-hand LUTs” as distributed RAM. This type of memory affords moderate amounts of data buffering anywhere along a data path. One left-hand LUT stores 16 bits. Multiple left-hand LUTs can be combined in various ways to store larger amounts of data. A dual port option combines two LUTs so that memory access is possible from two independent data lines. A Distributed ROM option permits pre-loading the memory with data during FPGA configuration.

Second, it is possible to program each left-hand LUT as a 16-bit shift register. Used in this way, each LUT can delay serial data anywhere from one to 16 clock cycles. The four left-hand LUTs of a single CLB can be combined to produce delays up to 64 clock cycles. The SHIFTIN and SHIFTOUT lines cascade LUTs to form larger shift registers. It is also possible to combine shift registers across more than one CLB. The resulting programmable delays can be used to balance the timing of data pipelines.

## Block RAM Overview

All Spartan-3 devices support block RAM, which is organized as configurable, synchronous 18Kbit blocks. Block RAM stores relatively large amounts of data more efficiently than the distributed RAM feature described earlier. (The latter is better suited for buffering small amounts of data anywhere along signal paths.) This section describes basic Block RAM functions. For more information, refer to the chapter entitled “Using Block RAM” in [UG331](#).

The aspect ratio—i.e., width vs. depth—of each block RAM is configurable. Furthermore, multiple blocks can be cascaded to create still wider and/or deeper memories.

A choice among primitives determines whether the block RAM functions as dual- or single-port memory. A name of the form RAMB16\_S[w<sub>A</sub>][w<sub>B</sub>] calls out the dual-port primitive, where the integers w<sub>A</sub> and w<sub>B</sub> specify the total data path width at ports w<sub>A</sub> and w<sub>B</sub>, respectively. Thus, a RAMB16\_S9\_S18 is a dual-port RAM with a 9-bit-wide Port A and an 18-bit-wide Port B. A name of the form RAMB16\_S[w] identifies the single-port primitive, where the integer w specifies the total data path width of the lone port. A RAMB16\_S18 is a single-port RAM with an 18-bit-wide port. Other memory functions—e.g., FIFOs, data path width conversion, ROM, etc.—are readily available using the CORE Generator™ software, part of the Xilinx development software.

- Phase Shifting:** The DCM provides the ability to shift the phase of all its output clock signals with respect to its input clock signal.

The DCM has four functional components: the Delay-Locked Loop (DLL), the Digital Frequency Synthesizer (DFS), the Phase Shifter (PS), and the Status Logic. Each component has its associated signals, as shown in Figure 19.

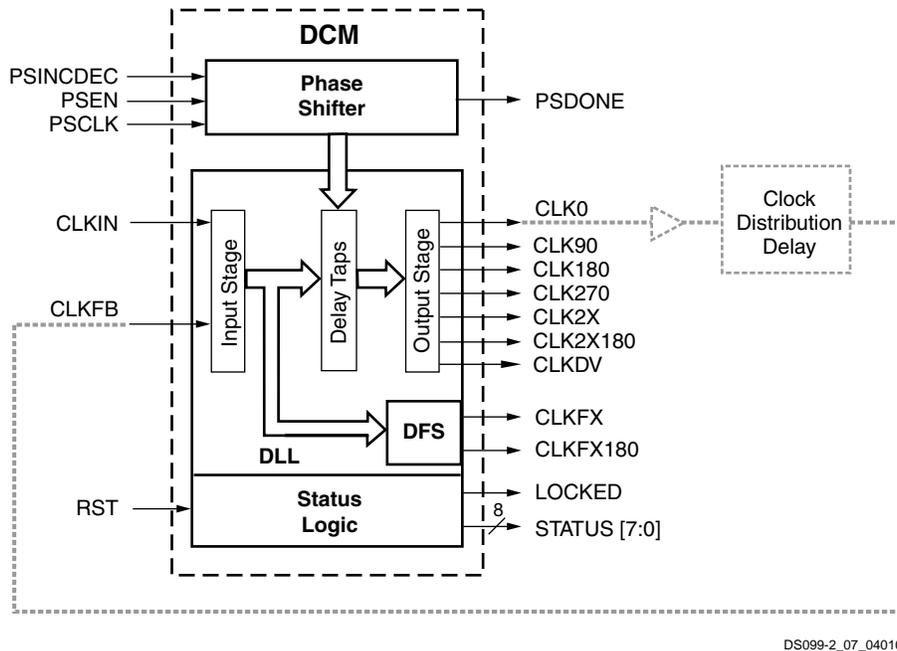


Figure 19: DCM Functional Blocks and Associated Signals

### Delay-Locked Loop (DLL)

The most basic function of the DLL component is to eliminate clock skew. The main signal path of the DLL consists of an input stage, followed by a series of discrete delay elements or *taps*, which in turn leads to an output stage. This path together with logic for phase detection and control forms a system complete with feedback as shown in Figure 20.

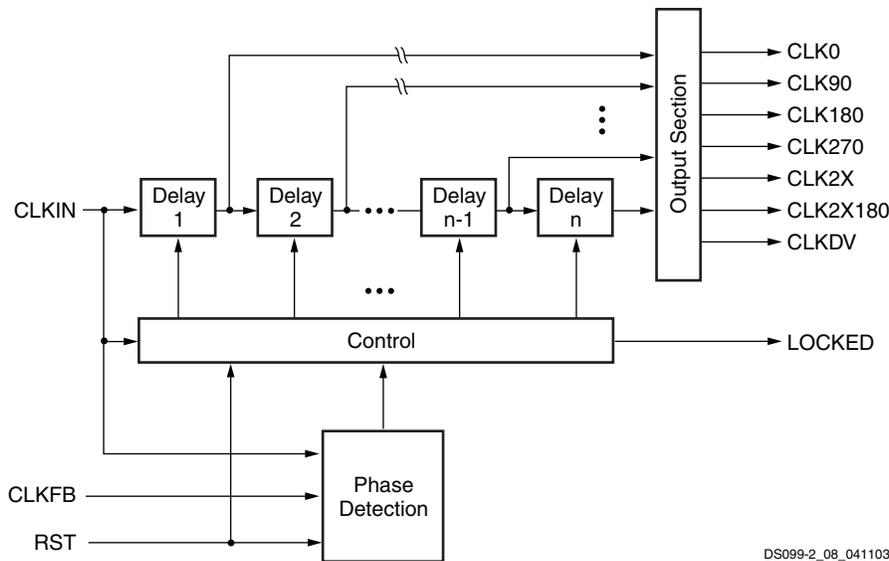


Figure 20: Simplified Functional Diagram of DLL

The output frequency ( $f_{CLKFX}$ ) can be expressed as a function of the incoming clock frequency ( $f_{CLKIN}$ ) as follows:

$$f_{CLKFX} = f_{CLKIN}(\text{CLKFX\_MULTIPLY}/\text{CLKFX\_DIVIDE}) \quad \text{Equation 3}$$

Regarding the two attributes, it is possible to assign any combination of integer values, provided that two conditions are met:

- The two values fall within their corresponding ranges, as specified in [Table 18](#).
- The  $f_{CLKFX}$  frequency calculated from the above expression accords with the DCM's operating frequency specifications.

For example, if `CLKFX_MULTIPLY = 5` and `CLKFX_DIVIDE = 3`, then the frequency of the output clock signal would be 5/3 that of the input clock signal.

### DFS Frequency Modes

The DFS supports two operating modes, High Frequency and Low Frequency, with each specified over a different clock frequency range. The `DFS_FREQUENCY_MODE` attribute chooses between the two modes. When the attribute is set to `LOW`, the Low Frequency mode permits the two DFS outputs to operate over a low-to-moderate frequency range. When the attribute is set to `HIGH`, the High Frequency mode allows both these outputs to operate at the highest possible frequencies.

### DFS With or Without the DLL

The DFS component can be used with or without the DLL component:

Without the DLL, the DFS component multiplies or divides the `CLKIN` signal frequency according to the respective `CLKFX_MULTIPLY` and `CLKFX_DIVIDE` values, generating a clock with the new target frequency on the `CLKFX` and `CLKFX180` outputs. Though classified as belonging to the DLL component, the `CLKIN` input is shared with the DFS component. This case does not employ feedback loop; therefore, it cannot correct for clock distribution delay.

With the DLL, the DFS operates as described in the preceding case, only with the additional benefit of eliminating the clock distribution delay. In this case, a feedback loop from the `CLK0` output to the `CLKFB` input must be present.

The DLL and DFS components work together to achieve this phase correction as follows: Given values for the `CLKFX_MULTIPLY` and `CLKFX_DIVIDE` attributes, the DLL selects the delay element for which the output clock edge coincides with the input clock edge whenever mathematically possible. For example, when `CLKFX_MULTIPLY = 5` and `CLKFX_DIVIDE = 3`, the input and output clock edges will coincide every three input periods, which is equivalent in time to five output periods.

Smaller `CLKFX_MULTIPLY` and `CLKFX_DIVIDE` values achieve faster lock times. With no factors common to the two attributes, alignment will occur once with every number of cycles equal to the `CLKFX_DIVIDE` value. Therefore, it is recommended that the user reduce these values by factoring wherever possible. For example, given `CLKFX_MULTIPLY = 9` and `CLKFX_DIVIDE = 6`, removing a factor of three yields `CLKFX_MULTIPLY = 3` and `CLKFX_DIVIDE = 2`. While both value-pairs will result in the multiplication of clock frequency by 3/2, the latter value-pair will enable the DLL to lock more quickly.

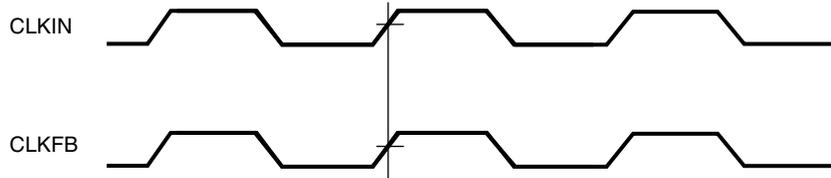
*Table 18: DFS Attributes*

Attribute	Description	Values
<code>DFS_FREQUENCY_MODE</code>	Chooses between High Frequency and Low Frequency modes	Low, High
<code>CLKFX_MULTIPLY</code>	Frequency multiplier constant	Integer from 2 to 32
<code>CLKFX_DIVIDE</code>	Frequency divisor constant	Integer from 1 to 32

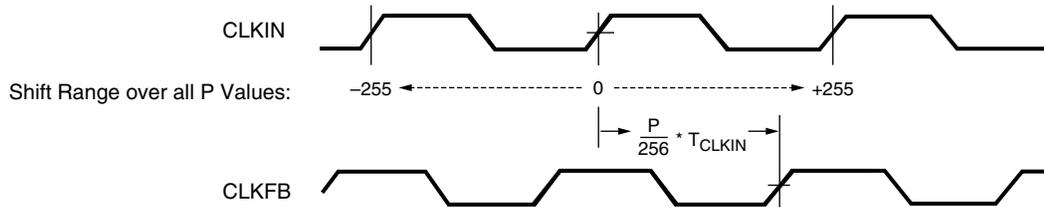
*Table 19: DFS Signals*

Signal	Direction	Description
<code>CLKFX</code>	Output	Multiplies the <code>CLKIN</code> frequency by the attribute-value ratio ( <code>CLKFX_MULTIPLY/CLKFX_DIVIDE</code> ) to generate a clock signal with a new target frequency.
<code>CLKFX180</code>	Output	Generates a clock signal with same frequency as <code>CLKFX</code> , only shifted 180° out-of-phase.

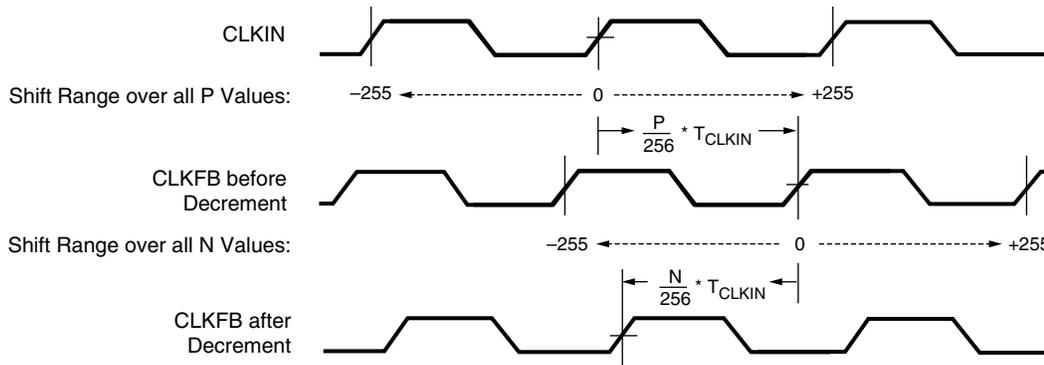
a. CLKOUT\_PHASE\_SHIFT = NONE



b. CLKOUT\_PHASE\_SHIFT = FIXED



c. CLKOUT\_PHASE\_SHIFT = VARIABLE



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Notes:

1. P represents the integer value ranging from -255 to +255 to which the PHASE\_SHIFT attribute is assigned.
2. N is an integer value ranging from -255 to +255 that represents the net phase shift effect from a series of increment and/or decrement operations.  
 $N = \{\text{Total number of increments}\} - \{\text{Total number of decrements}\}$   
 A positive value for N indicates a net increment; a negative value indicates a net decrement.

Figure 23: Phase Shifter Waveforms

## The Status Logic Component

The Status Logic component not only reports on the state of the DCM but also provides a means of resetting the DCM to an initial known state. The signals associated with the Status Logic component are described in [Table 22](#).

As a rule, the Reset (RST) input is asserted only upon configuring the device or changing the CLKIN frequency. A DCM reset does not affect attribute values (e.g., CLKFX\_MULTIPLY and CLKFX\_DIVIDE). If not used, RST must be tied to GND.

The eight bits of the STATUS bus are defined in [Table 23](#).



Table 45: Timing for the IOB Output Path

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max <sup>(3)</sup>	Max <sup>(3)</sup>	
<b>Clock-to-Output Times</b>						
T <sub>IOCKP</sub>	When reading from the Output Flip-Flop (OFF), the time from the active transition at the OTCLK input to data appearing at the Output pin	LVCMOS25 <sup>(2)</sup> , 12 mA output drive, Fast slew rate	XC3S200 XC3S400	1.28	1.47	ns
			XC3S50 XC3S1000 XC3S1500 XC3S2000 XC3S4000 XC3S5000	1.95	2.24	ns
<b>Propagation Times</b>						
T <sub>IOOP</sub>	The time it takes for data to travel from the IOB's O input to the Output pin	LVCMOS25 <sup>(2)</sup> , 12 mA output drive, Fast slew rate	XC3S200 XC3S400	1.28	1.46	ns
			XC3S50 XC3S1000 XC3S1500 XC3S2000 XC3S4000 XC3S5000	1.94	2.23	ns
T <sub>IOOLP</sub>	The time it takes for data to travel from the O input through the OFF latch to the Output pin		XC3S200 XC3S400	1.28	1.47	ns
			XC3S50 XC3S1000 XC3S1500 XC3S2000 XC3S4000 XC3S5000	1.95	2.24	ns
<b>Set/Reset Times</b>						
T <sub>IOSRP</sub>	Time from asserting the OFF's SR input to setting/resetting data at the Output pin	LVCMOS25 <sup>(2)</sup> , 12 mA output drive, Fast slew rate	XC3S200 XC3S400	2.10	2.41	ns
			XC3S50 XC3S1000 XC3S1500 XC3S2000 XC3S4000 XC3S5000	2.77	3.18	ns
T <sub>IOGSRQ</sub>	Time from asserting the Global Set Reset (GSR) net to setting/resetting data at the Output pin		All	8.07	9.28	ns

**Notes:**

1. The numbers in this table are tested using the methodology presented in Table 48 and are based on the operating conditions set forth in Table 32 and Table 35.
2. This time requires adjustment whenever a signal standard other than LVCMOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. When this is true, *add* the appropriate Output adjustment from Table 47.
3. For minimums, use the values reported by the Xilinx timing analyzer.

**Table 54: Synchronous 18 x 18 Multiplier Timing**

Symbol	Description	P Outputs	Speed Grade				Units
			-5		-4		
			Min	Max	Min	Max	
<b>Clock-to-Output Times</b>							
$T_{MULTCK}$	When reading from the Multiplier, the time from the active transition at the C clock input to data appearing at the P outputs	P[0]	–	1.00	–	1.15	ns
		P[15]	–	1.15	–	1.32	ns
		P[17]	–	1.30	–	1.50	ns
		P[19]	–	1.45	–	1.67	ns
		P[23]	–	1.76	–	2.02	ns
		P[31]	–	2.37	–	2.72	ns
		P[35]	–	2.67	–	3.07	ns
<b>Setup Times</b>							
$T_{MULIDCK}$	Time from the setup of data at the A and B inputs to the active transition at the C input of the Multiplier	-	1.84	–	2.11	–	ns
<b>Hold Times</b>							
$T_{MULCKID}$	Time from the active transition at the Multiplier's C input to the point where data is last held at the A and B inputs	-	0	–	0	–	ns

**Notes:**

- The numbers in this table are based on the operating conditions set forth in [Table 32](#).

**Table 55: Asynchronous 18 x 18 Multiplier Timing**

Symbol	Description	P Outputs	Speed Grade		Units
			-5	-4	
			Max	Max	
<b>Propagation Times</b>					
$T_{MULT}$	The time it takes for data to travel from the A and B inputs to the P outputs	P[0]	1.55	1.78	ns
		P[15]	3.15	3.62	ns
		P[17]	3.36	3.86	ns
		P[19]	3.49	4.01	ns
		P[23]	3.73	4.29	ns
		P[31]	4.23	4.86	ns
		P[35]	4.47	5.14	ns

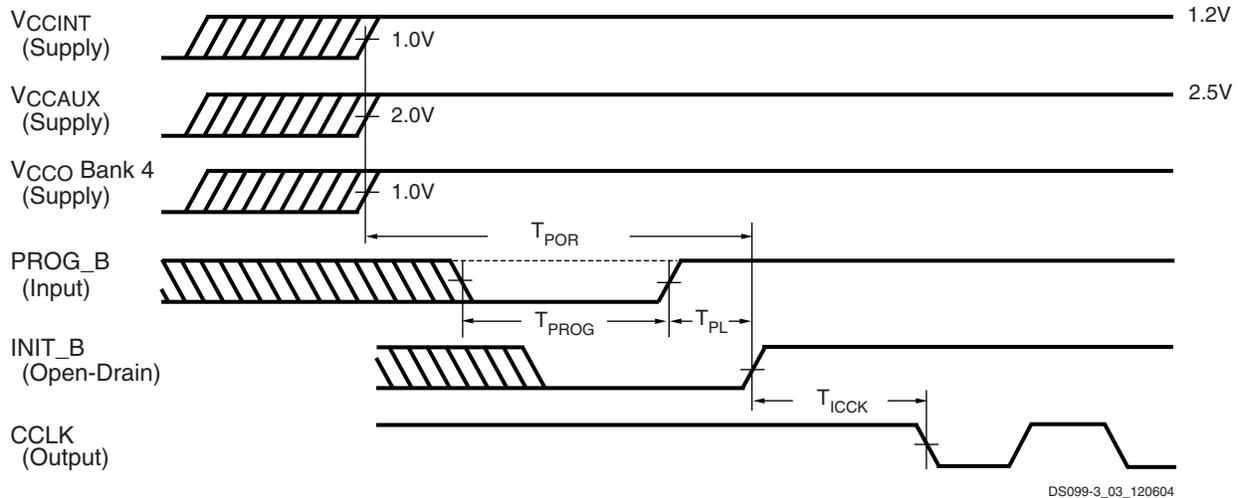
**Notes:**

- The numbers in this table are based on the operating conditions set forth in [Table 32](#).

Table 59: Switching Characteristics for the DLL

Symbol	Description	Frequency Mode / FCLKIN Range	Device	Speed Grade				Units
				-5		-4		
				Min	Max	Min	Max	
<b>Output Frequency Ranges</b>								
CLKOUT_FREQ_1X_LF	Frequency for the CLK0, CLK90, CLK180, and CLK270 outputs	Low	All	18	167	18	167	MHz
CLKOUT_FREQ_1X_HF	Frequency for the CLK0 and CLK180 outputs	High		48	280	48	280	MHz
CLKOUT_FREQ_2X_LF <sup>(3)</sup>	Frequency for the CLK2X and CLK2X180 outputs	Low		36	334	36	334	MHz
CLKOUT_FREQ_DV_LF	Frequency for the CLKDV output	Low		1.125	110	1.125	110	MHz
CLKOUT_FREQ_DV_HF		High		3	185	3	185	MHz
<b>Output Clock Jitter<sup>(4)</sup></b>								
CLKOUT_PER_JITT_0	Period jitter at the CLK0 output	All	All	–	±100	–	±100	ps
CLKOUT_PER_JITT_90	Period jitter at the CLK90 output			–	±150	–	±150	ps
CLKOUT_PER_JITT_180	Period jitter at the CLK180 output			–	±150	–	±150	ps
CLKOUT_PER_JITT_270	Period jitter at the CLK270 output			–	±150	–	±150	ps
CLKOUT_PER_JITT_2X	Period jitter at the CLK2X and CLK2X180 outputs			–	±200	–	±200	ps
CLKOUT_PER_JITT_DV1	Period jitter at the CLKDV output when performing integer division			–	±150	–	±150	ps
CLKOUT_PER_JITT_DV2	Period jitter at the CLKDV output when performing non-integer division			–	±300	–	±300	ps
<b>Duty Cycle</b>								
CLKOUT_DUTY_CYCLE_DLL <sup>(5)</sup>	Duty cycle variation for the CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, and CLKDV outputs	All	XC3S50	–	±150	–	±150	ps
			XC3S200	–	±150	–	±150	ps
			XC3S400	–	±250	–	±250	ps
			XC3S1000	–	±400	–	±400	ps
			XC3S1500	–	±400	–	±400	ps
			XC3S2000	–	±400	–	±400	ps
			XC3S4000	–	±400	–	±400	ps
			XC3S5000	–	±400	–	±400	ps
<b>Phase Alignment</b>								
CLKIN_CLKFB_PHASE	Phase offset between the CLKIN and CLKFB inputs	All	All	–	±150	–	±150	ps
CLKOUT_PHASE	Phase offset between any two DLL outputs (except CLK2X and CLK0)			–	±140	–	±140	ps
	Phase offset between the CLK2X and CLK0 outputs			–	±250	–	±250	ps

**Configuration and JTAG Timing**



**Notes:**

1. The  $V_{CCINT}$ ,  $V_{CCAUX}$ , and  $V_{CCO}$  supplies may be applied in any order.
2. The Low-going pulse on PROG\_B is optional after power-on but necessary for reconfiguration without a power cycle.
3. The rising edge of INIT\_B samples the voltage levels applied to the mode pins (M0 - M2).

*Figure 36: Waveforms for Power-On and the Beginning of Configuration*

*Table 65: Power-On Timing and the Beginning of Configuration*

Symbol	Description	Device	All Speed Grades		Units
			Min	Max	
$T_{POR}^{(2)}$	The time from the application of $V_{CCINT}$ , $V_{CCAUX}$ , and $V_{CCO}$ Bank 4 supply voltage ramps (whichever occurs last) to the rising transition of the INIT_B pin	XC3S50	–	5	ms
		XC3S200	–	5	ms
		XC3S400	–	5	ms
		XC3S1000	–	5	ms
		XC3S1500	–	7	ms
		XC3S2000	–	7	ms
		XC3S4000	–	7	ms
		XC3S5000	–	7	ms
$T_{PROG}$	The width of the low-going pulse on the PROG_B pin	All	0.3	–	$\mu$ s
$T_{PL}^{(2)}$	The time from the rising edge of the PROG_B pin to the rising transition on the INIT_B pin	XC3S50	–	2	ms
		XC3S200	–	2	ms
		XC3S400	–	2	ms
		XC3S1000	–	2	ms
		XC3S1500	–	3	ms
		XC3S2000	–	3	ms
		XC3S4000	–	3	ms
		XC3S5000	–	3	ms
$T_{INIT}$	Minimum Low pulse width on INIT_B output	All	250	–	ns
$T_{ICCK}^{(3)}$	The time from the rising edge of the INIT_B pin to the generation of the configuration clock signal at the CCLK output pin	All	0.25	4.0	$\mu$ s

**Notes:**

1. The numbers in this table are based on the operating conditions set forth in Table 32. This means power must be applied to all  $V_{CCINT}$ ,  $V_{CCO}$ , and  $V_{CCAUX}$  lines.
2. Power-on reset and the clearing of configuration memory occurs during this period.
3. This specification applies only for the Master Serial and Master Parallel modes.

### HSWAP\_EN: Disable Pull-up Resistors During Configuration

As shown in Table 76, a Low on this asynchronous pin enables pull-up resistors on all user I/Os not actively involved in the configuration process, although only until device configuration completes. A High disables the pull-up resistors during configuration, which is the desired state for some applications.

The dedicated configuration CONFIG pins (CCLK, DONE, PROG\_B, HSWAP\_EN, M2, M1, M0), the JTAG pins (TDI, TMS, TCK, TDO) and the INIT\_B always have active pull-up resistors during configuration, regardless of the value on HSWAP\_EN.

After configuration, HSWAP\_EN becomes a "don't care" input and any pull-up resistors previously enabled by HSWAP\_EN are disabled. If a user I/O in the application requires a pull-up resistor after configuration, place a PULLUP primitive on the associated I/O pin or, for some pins, set the associated bitstream generator option.

Table 76: HSWAP\_EN Encoding

HSWAP_EN	Function
<b>During Configuration</b>	
0	Enable pull-up resistors on all pins not actively involved in the configuration process. Pull-ups are only active until configuration completes. See Table 79.
1	No pull-up resistors during configuration.
<b>After Configuration, User Mode</b>	
X	This pin has no function except during device configuration.

**Notes:**

1. X = don't care, either 0 or 1.

The Bitstream generator option HswapenPin determines whether a pull-up resistor to VCCAUX, a pull-down resistor, or no resistor is present on HSWAP\_EN after configuration.

### JTAG: Dedicated JTAG Port Pins

Table 77: JTAG Pin Descriptions

Pin Name	Direction	Description	Bitstream Generation Option
TCK	Input	<b>Test Clock:</b> The TCK clock signal synchronizes all boundary scan operations on its rising edge.	The BitGen option <b>TckPin</b> determines whether a pull-up resistor, pull-down resistor or no resistor is present.
TDI	Input	<b>Test Data Input:</b> TDI is the serial data input for all JTAG instruction and data registers. This input is sampled on the rising edge of TCK.	The BitGen option <b>TdiPin</b> determines whether a pull-up resistor, pull-down resistor or no resistor is present.
TMS	Input	<b>Test Mode Select:</b> The TMS input controls the sequence of states through which the JTAG TAP state machine passes. This input is sampled on the rising edge of TCK.	The BitGen option <b>TmsPin</b> determines whether a pull-up resistor, pull-down resistor or no resistor is present.
TDO	Output	<b>Test Data Output:</b> The TDO pin is the data output for all JTAG instruction and data registers. This output is sampled on the rising edge of TCK. The TDO output is an active totem-pole driver and is not like the open-collector TDO output on Virtex®-II Pro FPGAs.	The BitGen option <b>TdoPin</b> determines whether a pull-up resistor, pull-down resistor or no resistor is present.

These pins are dedicated connections to the four-wire IEEE 1532/IEEE 1149.1 JTAG port, shown in Figure 43 and described in Table 77. The JTAG port is used for boundary-scan testing, device configuration, application debugging, and possibly an additional serial port for the application. These pins are dedicated and are not available as user-I/O pins. Every package has four dedicated JTAG pins and these pins are powered by the +2.5V VCCAUX supply.

For additional information on JTAG configuration, see [Boundary-Scan \(JTAG\) Mode, page 50](#).

## Mechanical Drawings

Detailed mechanical drawings for each package type are available from the Xilinx website at the specified location in [Table 83](#).

Material Declaration Data Sheets (MDDS) are also available on the [Xilinx website](#) for each package.

*Table 83: Xilinx Package Mechanical Drawings*

Package	Web Link (URL)
VQ100 and VQG100	<a href="http://www.xilinx.com/support/documentation/package_specs/vq100.pdf">http://www.xilinx.com/support/documentation/package_specs/vq100.pdf</a>
CP132 and CPG132 <sup>(1)</sup>	<a href="http://www.xilinx.com/support/documentation/package_specs/cp132.pdf">http://www.xilinx.com/support/documentation/package_specs/cp132.pdf</a>
TQ144 and TQG144	<a href="http://www.xilinx.com/support/documentation/package_specs/tq144.pdf">http://www.xilinx.com/support/documentation/package_specs/tq144.pdf</a>
PQ208 and PQG208	<a href="http://www.xilinx.com/support/documentation/package_specs/pq208.pdf">http://www.xilinx.com/support/documentation/package_specs/pq208.pdf</a>
FT256 and FTG256	<a href="http://www.xilinx.com/support/documentation/package_specs/ft256.pdf">http://www.xilinx.com/support/documentation/package_specs/ft256.pdf</a>
FG320 and FGG320	<a href="http://www.xilinx.com/support/documentation/package_specs/fg320.pdf">http://www.xilinx.com/support/documentation/package_specs/fg320.pdf</a>
FG456 and FGG456	<a href="http://www.xilinx.com/support/documentation/package_specs/fg456.pdf">http://www.xilinx.com/support/documentation/package_specs/fg456.pdf</a>
FG676 and FGG676	<a href="http://www.xilinx.com/support/documentation/package_specs/fg676.pdf">http://www.xilinx.com/support/documentation/package_specs/fg676.pdf</a>
FG900 and FGG900	<a href="http://www.xilinx.com/support/documentation/package_specs/fg900.pdf">http://www.xilinx.com/support/documentation/package_specs/fg900.pdf</a>
FG1156 and FGG1156 <sup>(1)</sup>	<a href="http://www.xilinx.com/support/documentation/package_specs/fg1156.pdf">http://www.xilinx.com/support/documentation/package_specs/fg1156.pdf</a>

### Notes:

1. The CP132, CPG132, FG1156, and FGG1156 packages are discontinued. See [http://www.xilinx.com/support/documentation/spartan-3\\_customer\\_notices.htm](http://www.xilinx.com/support/documentation/spartan-3_customer_notices.htm).

## Power, Ground, and I/O by Package

Each package has three separate voltage supply inputs—VCCINT, VCCAUX, and VCCO—and a common ground return, GND. The numbers of pins dedicated to these functions varies by package, as shown in [Table 84](#).

*Table 84: Power and Ground Supply Pins by Package*

Package	VCCINT	VCCAUX	VCCO	GND
VQ100	4	4	8	10
CP132 <sup>(1)</sup>	4	4	12	12
TQ144	4	4	12	16
PQ208	4	8	12	28
FT256	8	8	24	32
FG320	12	8	28	40
FG456	12	8	40	52
FG676	20	16	64	76
FG900	32	24	80	120
FG1156 <sup>(1)</sup>	40	32	104	184

### Notes:

1. The CP132, CPG132, FG1156, and FGG1156 packages are discontinued. See [http://www.xilinx.com/support/documentation/spartan-3\\_customer\\_notices.htm](http://www.xilinx.com/support/documentation/spartan-3_customer_notices.htm).

A majority of package pins are user-defined I/O pins. However, the numbers and characteristics of these I/O depends on the device type and the package in which it is available, as shown in [Table 85](#). The table shows the maximum number of single-ended I/O pins available, assuming that all I/O-, DUAL-, DCI-, VREF-, and GCLK-type pins are used as general-purpose I/O. Likewise, the table shows the maximum number of differential pin-pairs available on the package. Finally, the table shows how the total maximum user I/Os are distributed by pin type, including the number of unconnected—i.e., N.C.—pins on the device.

## PQ208: 208-lead Plastic Quad Flat Pack

The 208-lead plastic quad flat package, PQ208, supports three different Spartan-3 devices, including the XC3S50, the XC3S200, and the XC3S400. The footprints for the XC3S200 and XC3S400 are identical, as shown in [Table 93](#) and [Figure 47](#). The XC3S50, however, has fewer I/O pins resulting in 17 unconnected pins on the PQ208 package, labeled as “N.C.” In [Table 93](#) and [Figure 47](#), these unconnected pins are indicated with a black diamond symbol (◆).

All the package pins appear in [Table 93](#) and are sorted by bank number, then by pin name. Pairs of pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type, as defined earlier.

If there is a difference between the XC3S50 pinout and the pinout for the XC3S200 and XC3S400, then that difference is highlighted in [Table 93](#). If the table entry is shaded grey, then there is an unconnected pin on the XC3S50 that maps to a user-I/O pin on the XC3S200 and XC3S400. If the table entry is shaded tan, then the unconnected pin on the XC3S50 maps to a VREF-type pin on the XC3S200 and XC3S400. If the other VREF pins in the bank all connect to a voltage reference to support a special I/O standard, then also connect the N.C. pin on the XC3S50 to the same VREF voltage. This provides maximum flexibility as you could potentially migrate a design from the XC3S50 device to an XC3S200 or XC3S400 FPGA without changing the printed circuit board.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at [http://www.xilinx.com/support/documentation/data\\_sheets/s3\\_pin.zip](http://www.xilinx.com/support/documentation/data_sheets/s3_pin.zip)

### Pinout Table

*Table 93: PQ208 Package Pinout*

Bank	XC3S50 Pin Name	XC3S200, XC3S400 Pin Names	PQ208 Pin Number	Type
0	IO	IO	P189	I/O
0	IO	IO	P197	I/O
0	N.C. (◆)	IO/VREF_0	P200	VREF
0	IO/VREF_0	IO/VREF_0	P205	VREF
0	IO_L01N_0/VRP_0	IO_L01N_0/VRP_0	P204	DCI
0	IO_L01P_0/VRN_0	IO_L01P_0/VRN_0	P203	DCI
0	IO_L25N_0	IO_L25N_0	P199	I/O
0	IO_L25P_0	IO_L25P_0	P198	I/O
0	IO_L27N_0	IO_L27N_0	P196	I/O
0	IO_L27P_0	IO_L27P_0	P194	I/O
0	IO_L30N_0	IO_L30N_0	P191	I/O
0	IO_L30P_0	IO_L30P_0	P190	I/O
0	IO_L31N_0	IO_L31N_0	P187	I/O
0	IO_L31P_0/VREF_0	IO_L31P_0/VREF_0	P185	VREF
0	IO_L32N_0/GCLK7	IO_L32N_0/GCLK7	P184	GCLK
0	IO_L32P_0/GCLK6	IO_L32P_0/GCLK6	P183	GCLK
0	VCCO_0	VCCO_0	P188	VCCO
0	VCCO_0	VCCO_0	P201	VCCO
1	IO	IO	P167	I/O
1	IO	IO	P175	I/O
1	IO	IO	P182	I/O
1	IO_L01N_1/VRP_1	IO_L01N_1/VRP_1	P162	DCI
1	IO_L01P_1/VRN_1	IO_L01P_1/VRN_1	P161	DCI

## User I/Os by Bank

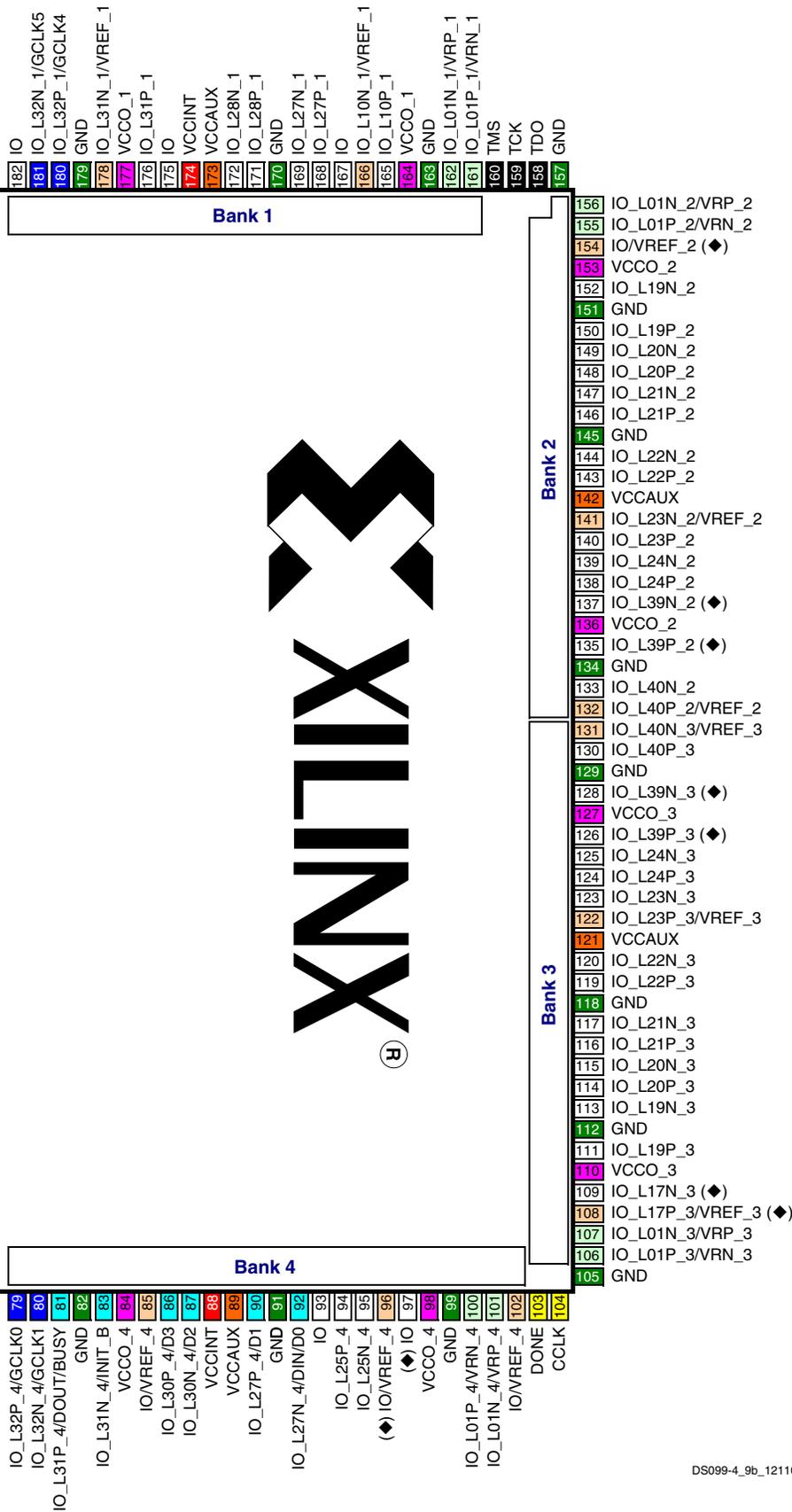
Table 94 indicates how the available user-I/O pins are distributed between the eight I/O banks for the XC3S50 in the PQ208 package. Similarly, Table 95 shows how the available user-I/O pins are distributed between the eight I/O banks for the XC3S200 and XC3S400 in the PQ208 package.

Table 94: User I/Os Per Bank for XC3S50 in PQ208 Package

Package Edge	I/O Bank	Maximum I/O	All Possible I/O Pins by Type				
			I/O	DUAL	DCI	VREF	GCLK
Top	0	15	9	0	2	2	2
	1	15	9	0	2	2	2
Right	2	16	13	0	2	2	0
	3	16	12	0	2	2	0
Bottom	4	15	3	6	2	2	2
	5	15	3	6	2	2	2
Left	6	16	12	0	2	2	0
	7	16	12	0	2	2	0

Table 95: User I/Os Per Bank for XC3S200 and XC3S400 in PQ208 Package

Package Edge	I/O Bank	Maximum I/O	All Possible I/O Pins by Type				
			I/O	DUAL	DCI	VREF	GCLK
Top	0	16	9	0	2	3	2
	1	15	9	0	2	2	2
Right	2	19	14	0	2	3	0
	3	20	15	0	2	3	0
Bottom	4	17	4	6	2	3	2
	5	15	3	6	2	2	2
Left	6	19	14	0	2	3	0
	7	20	15	0	2	3	0



Right Half of Package  
(Top View)

Figure 48: PQ208 Package Footprint (Top View) Continued

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Table 98: FG320 Package Pinout (Cont'd)

Bank	XC3S400, XC3S1000, XC3S1500 Pin Name	FG320 Pin Number	Type
2	IO_L20N_2	E17	I/O
2	IO_L20P_2	E18	I/O
2	IO_L21N_2	F15	I/O
2	IO_L21P_2	E15	I/O
2	IO_L22N_2	F14	I/O
2	IO_L22P_2	G14	I/O
2	IO_L23N_2/VREF_2	G18	VREF
2	IO_L23P_2	F17	I/O
2	IO_L24N_2	G15	I/O
2	IO_L24P_2	G16	I/O
2	IO_L27N_2	H13	I/O
2	IO_L27P_2	H14	I/O
2	IO_L34N_2/VREF_2	H16	VREF
2	IO_L34P_2	H15	I/O
2	IO_L35N_2	H17	I/O
2	IO_L35P_2	H18	I/O
2	IO_L39N_2	J18	I/O
2	IO_L39P_2	J17	I/O
2	IO_L40N_2	J15	I/O
2	IO_L40P_2/VREF_2	J14	VREF
2	VCCO_2	F16	VCCO
2	VCCO_2	H12	VCCO
2	VCCO_2	J12	VCCO
3	IO	K15	I/O
3	IO_L01N_3/VRP_3	T17	DCI
3	IO_L01P_3/VRN_3	T16	DCI
3	IO_L16N_3	T18	I/O
3	IO_L16P_3	U18	I/O
3	IO_L17N_3	P16	I/O
3	IO_L17P_3/VREF_3	R16	VREF
3	IO_L19N_3	R17	I/O
3	IO_L19P_3	R18	I/O
3	IO_L20N_3	P18	I/O
3	IO_L20P_3	P17	I/O
3	IO_L21N_3	P15	I/O
3	IO_L21P_3	N15	I/O
3	IO_L22N_3	M14	I/O
3	IO_L22P_3	N14	I/O
3	IO_L23N_3	M15	I/O
3	IO_L23P_3/VREF_3	M16	VREF

Table 100: FG456 Package Pinout (Cont'd)

Bank	3S400 Pin Name	3S1000, 3S1500, 3S2000 Pin Name	FG456 Pin Number	Type
5	IO_L27N_5/VREF_5	IO_L27N_5/VREF_5	W9	VREF
5	IO_L27P_5	IO_L27P_5	V9	I/O
5	IO_L28N_5/D6	IO_L28N_5/D6	AB9	DUAL
5	IO_L28P_5/D7	IO_L28P_5/D7	AA9	DUAL
5	IO_L29N_5	IO_L29N_5	Y10	I/O
5	IO_L29P_5/VREF_5	IO_L29P_5/VREF_5	W10	VREF
5	IO_L30N_5	IO_L30N_5	AB10	I/O
5	IO_L30P_5	IO_L30P_5	AA10	I/O
5	IO_L31N_5/D4	IO_L31N_5/D4	W11	DUAL
5	IO_L31P_5/D5	IO_L31P_5/D5	V11	DUAL
5	IO_L32N_5/GCLK3	IO_L32N_5/GCLK3	AA11	GCLK
5	IO_L32P_5/GCLK2	IO_L32P_5/GCLK2	Y11	GCLK
5	VCCO_5	VCCO_5	T9	VCCO
5	VCCO_5	VCCO_5	T10	VCCO
5	VCCO_5	VCCO_5	T11	VCCO
5	VCCO_5	VCCO_5	U8	VCCO
5	VCCO_5	VCCO_5	Y8	VCCO
6	IO	IO	Y1	I/O
6	IO_L01N_6/VRP_6	IO_L01N_6/VRP_6	Y3	DCI
6	IO_L01P_6/VRN_6	IO_L01P_6/VRN_6	Y2	DCI
6	IO_L16N_6	IO_L16N_6	W4	I/O
6	IO_L16P_6	IO_L16P_6	W3	I/O
6	IO_L17N_6	IO_L17N_6	W2	I/O
6	IO_L17P_6/VREF_6	IO_L17P_6/VREF_6	W1	VREF
6	IO_L19N_6	IO_L19N_6	V5	I/O
6	IO_L19P_6	IO_L19P_6	U5	I/O
6	IO_L20N_6	IO_L20N_6	V4	I/O
6	IO_L20P_6	IO_L20P_6	V3	I/O
6	IO_L21N_6	IO_L21N_6	V2	I/O
6	IO_L21P_6	IO_L21P_6	V1	I/O
6	IO_L22N_6	IO_L22N_6	T6	I/O
6	IO_L22P_6	IO_L22P_6	T5	I/O
6	IO_L23N_6	IO_L23N_6	U4	I/O
6	IO_L23P_6	IO_L23P_6	T4	I/O
6	IO_L24N_6/VREF_6	IO_L24N_6/VREF_6	U3	VREF
6	IO_L24P_6	IO_L24P_6	U2	I/O
6	N.C. (◆)	IO_L26N_6	T3	I/O
6	N.C. (◆)	IO_L26P_6	R4	I/O
6	IO_L27N_6	IO_L27N_6	T2	I/O
6	IO_L27P_6	IO_L27P_6	T1	I/O

## FG676: 676-lead Fine-pitch Ball Grid Array

The 676-lead fine-pitch ball grid array package, FG676, supports five different Spartan-3 devices, including the XC3S1000, XC3S1500, XC3S2000, XC3S4000, and XC3S5000. All five have nearly identical footprints but are slightly different, primarily due to unconnected pins on the XC3S1000 and XC3S1500. For example, because the XC3S1000 has fewer I/O pins, this device has 98 unconnected pins on the FG676 package, labeled as “N.C.” In [Table 103](#) and [Figure 53](#), these unconnected pins are indicated with a black diamond symbol (◆). The XC3S1500, however, has only two unconnected pins, also labeled “N.C.” in the pinout table but indicated with a black square symbol (■).

All the package pins appear in [Table 103](#) and are sorted by bank number, then by pin name. Pairs of pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type, as defined earlier.

If there is a difference between the XC3S1000, XC3S1500, XC3S2000, XC3S4000, and XC3S5000 pinouts, then that difference is highlighted in [Table 103](#). If the table entry is shaded grey, then there is an unconnected pin on either the XC3S1000 or XC3S1500 that maps to a user-I/O pin on the XC3S2000, XC3S4000, and XC3S5000. If the table entry is shaded tan, then the unconnected pin on either the XC3S1000 or XC3S1500 maps to a VREF-type pin on the XC3S2000, XC3S4000, and XC3S5000. If the other VREF pins in the bank all connect to a voltage reference to support a special I/O standard, then also connect the N.C. pin on the XC3S1000 or XC3S1500 to the same VREF voltage. This provides maximum flexibility as you could potentially migrate a design from the XC3S1000 through to the XC3S5000 FPGA without changing the printed circuit board.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at [http://www.xilinx.com/support/documentation/data\\_sheets/s3\\_pin.zip](http://www.xilinx.com/support/documentation/data_sheets/s3_pin.zip).

### Pinout Table

Table 103: FG676 Package Pinout

Bank	XC3S1000 Pin Name	XC3S1500 Pin Name	XC3S2000 Pin Name	XC3S4000 Pin Name	XC3S5000 Pin Name	FG676 Pin Number	Type
0	IO	IO	IO	IO	IO_L04N_0 <sup>(3)</sup>	A3	I/O
0	IO	IO	IO	IO	IO	A5	I/O
0	IO	IO	IO	IO	IO	A6	I/O
0	IO	IO	IO	IO	IO_L04P_0 <sup>(3)</sup>	C4	I/O
0	N.C. (◆)	IO	IO	IO	IO_L13N_0 <sup>(3)</sup>	C8	I/O
0	IO	IO	IO	IO	IO	C12	I/O
0	IO	IO	IO	IO	IO	E13	I/O
0	IO	IO	IO	IO	IO	H11	I/O
0	IO	IO	IO	IO	IO	H12	I/O
0	IO/VREF_0	IO/VREF_0	IO/VREF_0	IO/VREF_0	IO/VREF_0	B3	VREF
0	IO/VREF_0	IO/VREF_0	IO/VREF_0	IO/VREF_0	IO/VREF_0	F7	VREF
0	IO/VREF_0	IO/VREF_0	IO/VREF_0	IO/VREF_0	IO/VREF_0	G10	VREF
0	IO_L01N_0/VRP_0	IO_L01N_0/VRP_0	IO_L01N_0/VRP_0	IO_L01N_0/VRP_0	IO_L01N_0/VRP_0	E5	DCI
0	IO_L01P_0/VRN_0	IO_L01P_0/VRN_0	IO_L01P_0/VRN_0	IO_L01P_0/VRN_0	IO_L01P_0/VRN_0	D5	DCI
0	IO_L05N_0	IO_L05N_0	IO_L05N_0	IO_L05N_0	IO_L05N_0	B4	I/O
0	IO_L05P_0/VREF_0	IO_L05P_0/VREF_0	IO_L05P_0/VREF_0	IO_L05P_0/VREF_0	IO_L05P_0/VREF_0	A4	VREF
0	IO_L06N_0	IO_L06N_0	IO_L06N_0	IO_L06N_0	IO_L06N_0	C5	I/O
0	IO_L06P_0	IO_L06P_0	IO_L06P_0	IO_L06P_0	IO_L06P_0	B5	I/O
0	IO_L07N_0	IO_L07N_0	IO_L07N_0	IO_L07N_0	IO_L07N_0	E6	I/O
0	IO_L07P_0	IO_L07P_0	IO_L07P_0	IO_L07P_0	IO_L07P_0	D6	I/O
0	IO_L08N_0	IO_L08N_0	IO_L08N_0	IO_L08N_0	IO_L08N_0	C6	I/O
0	IO_L08P_0	IO_L08P_0	IO_L08P_0	IO_L08P_0	IO_L08P_0	B6	I/O

## Revision History

Date	Version	Description
04/03/03	1.0	Initial Xilinx release.
04/21/03	1.1	Added information on the VQ100 package footprint, including a complete pinout table ( <a href="#">Table 87</a> ) and footprint diagram ( <a href="#">Figure 44</a> ). Updated <a href="#">Table 85</a> with final I/O counts for the VQ100 package. Also added final differential I/O pair counts for the TQ144 package. Added clarifying comments to HSWAP_EN pin description on <a href="#">page 119</a> . Updated the footprint diagram for the FG900 package shown in <a href="#">Figure 55a</a> and <a href="#">Figure 55b</a> . Some thick lines separating I/O banks were incorrect. Made cosmetic changes to <a href="#">Figure 40</a> , <a href="#">Figure 42</a> , and <a href="#">Figure 43</a> . Updated Xilinx hypertext links. Added XC3S200 and XC3S400 to Pin Name column in <a href="#">Table 91</a> .
05/12/03	1.1.1	AM32 pin was missing GND label in FG1156 package diagram ( <a href="#">Figure 53</a> ).
07/11/03	1.1.2	Corrected misspellings of GCLK in <a href="#">Table 69</a> and <a href="#">Table 70</a> . Changed CMOS25 to LVCMOS25 in <a href="#">Dual-Purpose Pin I/O Standard During Configuration</a> section. Clarified references to Module 2. For XC3S5000 in FG1156 package, corrected N.C. symbol to a black square in <a href="#">Table 110</a> , key, and package drawing.
07/29/03	1.2	Corrected pin names on FG1156 package. Some package balls incorrectly included LVDS pair names. The affected balls on the FG1156 package include G1, G2, G33, G34, U9, U10, U25, U26, V9, V10, V25, V26, AH1, AH2, AH33, AH34. The number of LVDS pairs is unaffected. Modified affected balls and re-sorted rows in <a href="#">Table 110</a> . Updated affected balls in <a href="#">Figure 53</a> . Also updated ASCII and Excel electronic versions of FG1156 pinout.
08/19/03	1.2.1	Removed 100 MHz ConfigRate option in <a href="#">CCLK: Configuration Clock</a> section and in <a href="#">Table 80</a> . Added note that TDO is a totem-pole output in <a href="#">Table 77</a> .
10/09/03	1.2.2	Some pins had incorrect bank designations and were improperly sorted in <a href="#">Table 93</a> . No pin names or functions changed. Renamed DCI_IN to DCI and added black diamond to N.C. pins in <a href="#">Table 93</a> . In <a href="#">Figure 47</a> , removed some extraneous text from pin 106 and corrected spelling of pins 45, 48, and 81.
12/17/03	1.3	Added FG320 pin tables and pinout diagram ( <a href="#">FG320: 320-lead Fine-pitch Ball Grid Array</a> ). Made cosmetic changes to the TQ144 footprint ( <a href="#">Figure 46</a> ), the PQ208 footprint ( <a href="#">Figure 47</a> ), the FG676 footprint ( <a href="#">Figure 53</a> ), and the FG900 footprint ( <a href="#">Figure 55</a> ). Clarified wording in <a href="#">Precautions When Using the JTAG Port in 3.3V Environments</a> section.
02/27/04	1.4	Clarified wording in <a href="#">Using JTAG Port After Configuration</a> section. In <a href="#">Table 81</a> , reduced package height for FG320 and increased maximum I/O values for the FG676, FG900, and FG1156 packages.
07/13/04	1.5	Added information on lead-free (Pb-free) package options to the <a href="#">Package Overview</a> section plus <a href="#">Table 81</a> and <a href="#">Table 83</a> . Clarified the VRN_# reference resistor requirements for I/O standards that use single termination as described in the <a href="#">DCI Termination Types</a> section and in <a href="#">Figure 42b</a> . Graduated from Advance Product Specification to Product Specification.
08/24/04	1.5.1	Removed XC3S2000 references from <a href="#">FG1156: 1156-lead Fine-pitch Ball Grid Array</a> .
01/17/05	1.6	Added XC3S50 in CP132 package option. Added XC3S2000 in FG456 package option. Added XC3S4000 in FG676 package option. Added <a href="#">Selecting the Right Package Option</a> section. Modified or added <a href="#">Table 81</a> , <a href="#">Table 83</a> , <a href="#">Table 84</a> , <a href="#">Table 85</a> , <a href="#">Table 89</a> , <a href="#">Table 90</a> , <a href="#">Table 100</a> , <a href="#">Table 102</a> , <a href="#">Table 103</a> , <a href="#">Table 106</a> , <a href="#">Figure 45</a> , and <a href="#">Figure 53</a> .
08/19/05	1.7	Removed term “weak” from the description of pull-up and pull-down resistors. Added <a href="#">IDCODE Register</a> values. Added signal integrity precautions to <a href="#">CCLK: Configuration Clock</a> and indicated that CCLK should be treated as an I/O during Master mode in <a href="#">Table 79</a> .
04/03/06	2.0	Added <a href="#">Package Thermal Characteristics</a> . Updated <a href="#">Figure 41</a> to make it a more obvious example. Added detail about which pins have dedicated pull-up resistors during configuration, regardless of the HSWAP_EN value to <a href="#">Table 70</a> and to <a href="#">Pin Behavior During Configuration</a> . Updated <a href="#">Precautions When Using the JTAG Port in 3.3V Environments</a> .
04/26/06	2.1	Corrected swapped data row in <a href="#">Table 86</a> . The Theta-JA with zero airflow column was swapped with the Theta-JC column. Made additional notations on CONFIG and JTAG pins that have pull-up resistors during configuration, regardless of the HSWAP_EN input.
05/25/07	2.2	Added link on <a href="#">page 128</a> to Material Declaration Data Sheets. Corrected units typo in <a href="#">Table 74</a> . Added Note 1 to <a href="#">Table 103</a> about VREF for XC3S1500 in FG676.